

Search Notes	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/748,577	LEE ET AL.
Examiner	Art Unit	
John J. Figueroa	1712	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
526	325	6/20/2007	JJF
427	412.5	6/20/2007	JJF